

# SLB120N10G

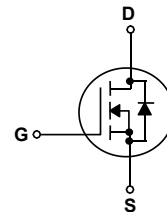
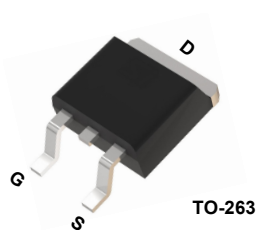
## 100V N -Channel MOSFET

### General Description

This Power MOSFET is produced using Msemitek's advanced Shielding Gate MOSFET technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as DC/DC converters and high efficiency switching for power management in portable and battery operated products.

### Features

- N-Channel: 100V 120A  
 $R_{DS(on)Typ} = 4.6m\Omega @ V_{GS} = 10V$
- Very Low On-resistance  $R_{DS(ON)}$
- Low  $C_{rss}$
- Fast switching
- 100% avalanche tested
- Improved  $dv/dt$  capability



### Absolute Maximum Ratings $T_C = 25^\circ C$ unless otherwise noted

| Symbol          | Parameter   | SLB120N10G  | Units        |
|-----------------|---|-------------|--------------|
| $V_{DSS}$       | Drain-Source Voltage  | 100         | V            |
| $I_D$           | Drain Current - Continuous ( $T_C = 25^\circ C$ )<br>- Continuous ( $T_C = 100^\circ C$ ) | 120         | A            |
|                 |   | 78          | A            |
| $I_{DM}$        | Drain Current - Pulsed (Note 1)   | 480         | A            |
| $V_{GSS}$       | Gate-Source Voltage   | $\pm 20$    | V            |
| $E_{AS}$        | Single Pulsed Avalanche Energy  | 625         | mJ           |
| $P_D$           | Power Dissipation ( $T_C = 25^\circ C$ )  | 190         | W            |
| $R_{\theta JC}$ | Thermal Resistance, Junction to Case  | 0.66        | $^\circ C/W$ |
| $T_J, T_{STG}$  | Operating and Storage Temperature Range   | -55 to +150 | $^\circ C$   |
| $T_L$           | Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds             | 300         | $^\circ C$   |

\* Drain current limited by maximum junction temperature.

## Package Marking

| Part Number | Top Marking | Package | Packing Method | MOQ | QTY  |
|-------------|-------------|---------|----------------|-----|------|
| SLB120N10G  | SLB120N10G  | TO-263  | Tape & Reel    | 800 | 4000 |

## Electrical Characteristics

$T_C = 25^\circ\text{C}$  unless otherwise noted

| Symbol | Parameter | Test Conditions | Min | Typ | Max | Units |
|--------|-----------|-----------------|-----|-----|-----|-------|
|--------|-----------|-----------------|-----|-----|-----|-------|

### Off Characteristics

|            |                                    |   |     |    |      |               |
|------------|------------------------------------|---|-----|----|------|---------------|
| $BV_{DSS}$ | Drain-Source Breakdown Voltage     | $V_{GS} = 0\text{ V}, I_D = 250\ \mu\text{A}$ | 100 | -- | --   | V             |
| $I_{DSS}$  | Zero Gate Voltage Drain Current    | $V_{DS} = 100\text{ V}, V_{GS} = 0\text{ V}$  | --  | -- | 1    | $\mu\text{A}$ |
| $I_{GSSF}$ | Gate-Body Leakage Current, Forward | $V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$   | --  | -- | 100  | nA            |
| $I_{GSSR}$ | Gate-Body Leakage Current, Reverse | $V_{GS} = -20\text{ V}, V_{DS} = 0\text{ V}$  | --  | -- | -100 | nA            |

### On Characteristics

|              |                                   |   |     |     |     |            |
|--------------|-----------------------------------|---|-----|-----|-----|------------|
| $V_{GS(th)}$ | Gate Threshold Voltage            | $V_{DS} = V_{GS}, I_D = 250\ \mu\text{A}$ | 2.0 | -   | 4.0 | V          |
| $R_{DS(on)}$ | Static Drain-Source On-Resistance | $V_{GS} = 10\text{ V}, I_D = 30\text{ A}$ | --  | 4.6 | 6   | m $\Omega$ |

### Dynamic Characteristics

|           |                              |  |    |      |   |    |
|-----------|------------------------------|--|----|------|---|----|
| $C_{iss}$ | Input Capacitance            | $V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V},$<br>$f = 1.0\text{ MHz}$ | -- | 3886 | - | pF |
| $C_{oss}$ | Output Capacitance           |  | -- | 1368 | - | pF |
| $C_{rss}$ | Reverse Transfer Capacitance |  | -- | 141  | - | pF |

### Switching Characteristics

|              |                     |   |    |      |    |    |
|--------------|---------------------|---|----|------|----|----|
| $t_{d(on)}$  | Turn-On Delay Time  | $V_{GS} = 10\text{ V}, V_{DS} = 50\text{ V},$<br>$R_L = 3\ \Omega, I_D = 20\text{ A}, T_J = 25^\circ\text{C}$ | -- | 50   | -- | ns |
| $t_r$        | Turn-On Rise Time   |   | -- | 75   | -- | ns |
| $t_{d(off)}$ | Turn-Off Delay Time |   | -- | 158  | -- | ns |
| $t_f$        | Turn-Off Fall Time  |   | -- | 90   | -- | ns |
| $Q_g$        | Total Gate Charge   | $V_{DS} = 50\text{ V}, I_D = 50\text{ A},$<br>$V_{GS} = 10\text{ V}$  | -- | 63.8 | -- | nC |
| $Q_{gs}$     | Gate-Source Charge  |   | -- | 18.7 | -- | nC |
| $Q_{gd}$     | Gate-Drain Charge   |   | -- | 20   | -- | nC |

### Drain-Source Diode Characteristics and Maximum Ratings

|          |  |    |    |     |    |
|----------|--|----|----|-----|----|
| $I_S$    | Maximum Continuous Drain-Source Diode Forward Current  | -- | -- | 120 | A  |
| $I_{SM}$ | Maximum Pulsed Drain-Source Diode Forward Current  | -- | -- | 480 | A  |
| $V_{SD}$ | Drain to Source Diode Forward Voltage, $V_{GS} = 0\text{ V}, I_{SD} = 30\text{ A}, T_J = 25^\circ\text{C}$ | -- | -- | 1.2 | V  |
| $T_{rr}$ | Reverse recovery time, $I_F = 20\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$                               | -- | -  | 61  | ns |
| $Q_{rr}$ | Reverse recovery charge, $I_F = 20\text{ A}, di/dt = 100\text{ A}/\mu\text{s}$                             | -- | -  | 105 | nC |

#### Notes:

1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
2. EAS condition:  $T_J = 25^\circ\text{C}, V_{DD} = 25\text{ V}, V_G = 10\text{ V}, L = 0.5\text{ mH}$ .
3. Pulse Test: Pulse Width  $\leq 300\ \mu\text{s}$ , Duty Cycle  $\leq 0.5\%$

### N- Channel Typical Characteristics

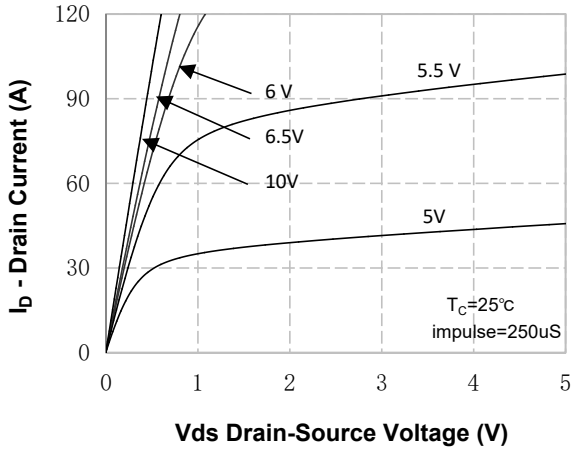


Figure 1. On-Region Characteristics

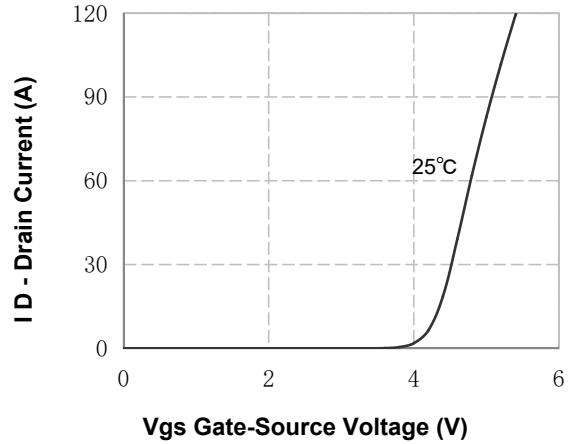


Figure 2. Transfer Characteristics

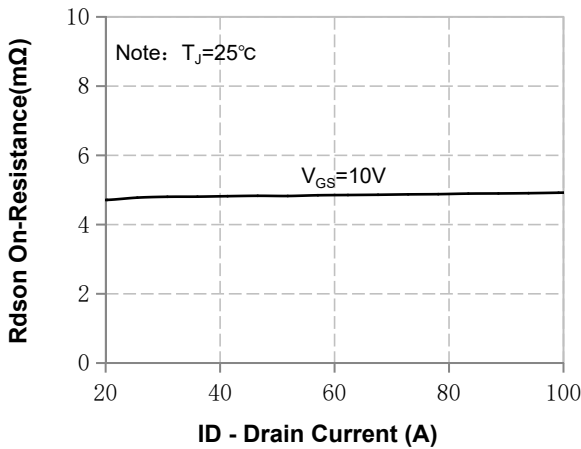


Figure 3. On-Resistance Variation vs Drain Current and Gate Voltage

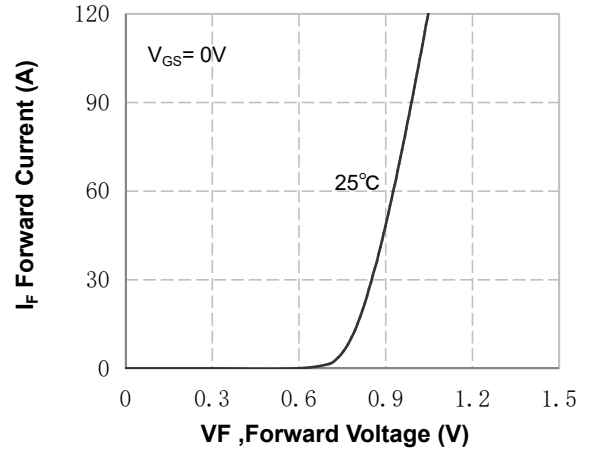


Figure 4. Body Diode Forward Voltage Variation with Source Current and Temperature

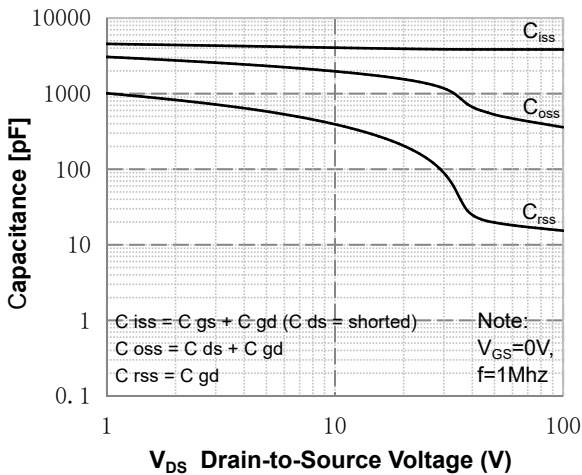


Figure 5. Capacitance Characteristics

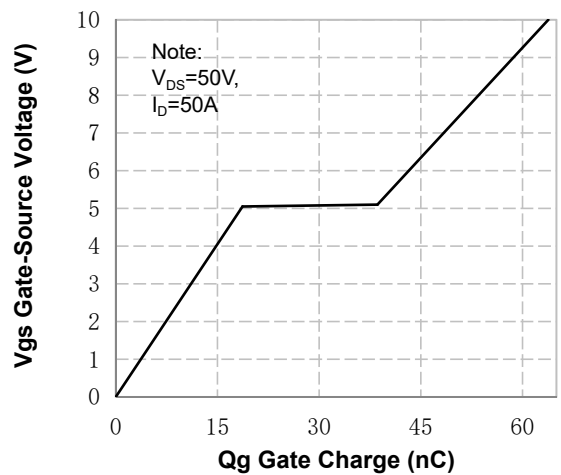
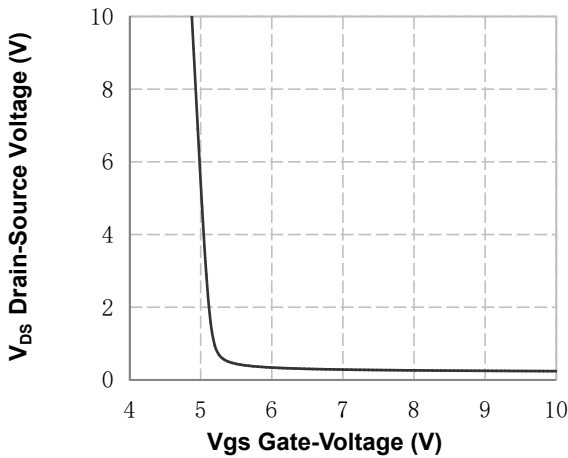
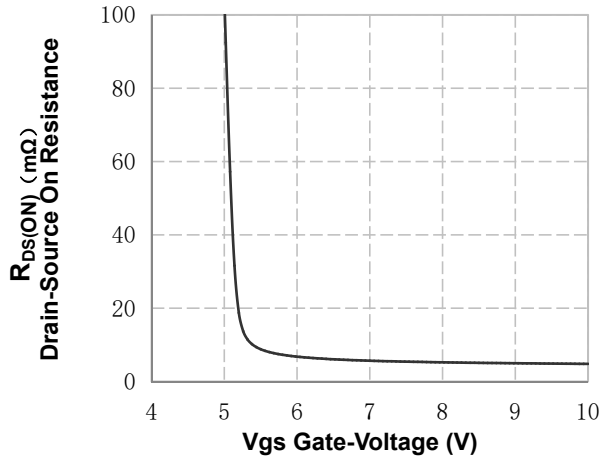


Figure 6. Gate Charge Characteristics

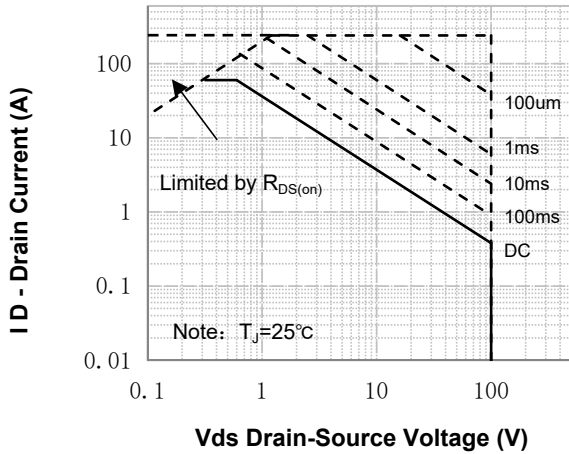
**N- Channel Typical Characteristics** (Continued)



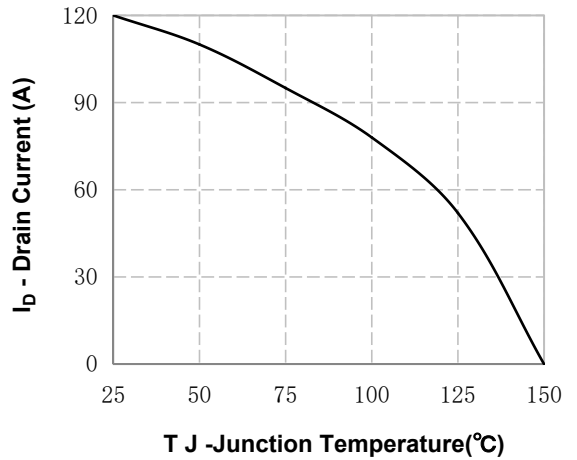
**Figure 7.  $V_{DS}$  Drain-Source Voltage vs Gate Voltage**



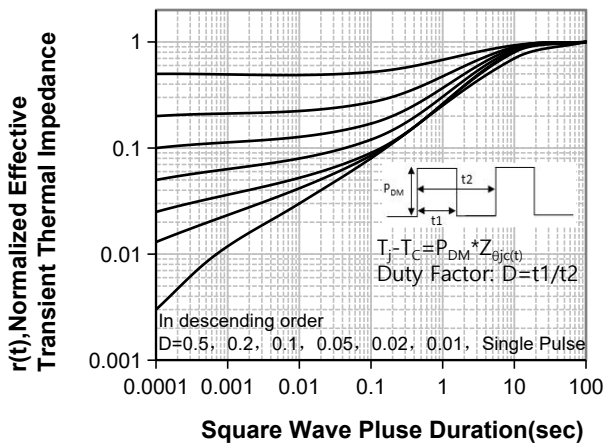
**Figure 8. On-Resistance vs Gate Voltage**



**Figure 9. Maximum Safe Operating Area**

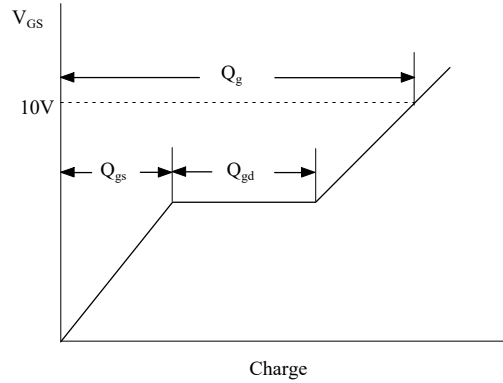


**Figure 10. Maximum Continuous Drain Current vs Temperature**



**Figure 11. Transient Thermal Response Curve**

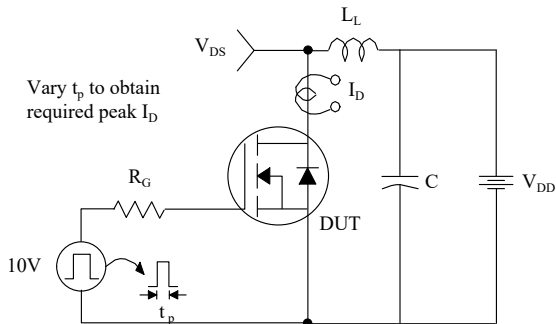
### Gate Charge Test Circuit & Waveform



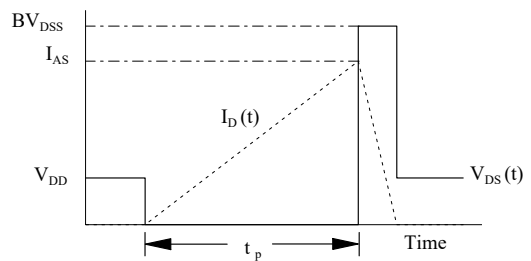
### Resistive Switching Test Circuit & Waveforms



### Unclamped Inductive Switching Test Circuit & Waveforms



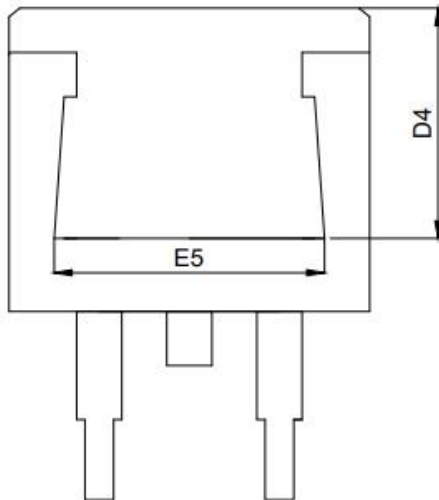
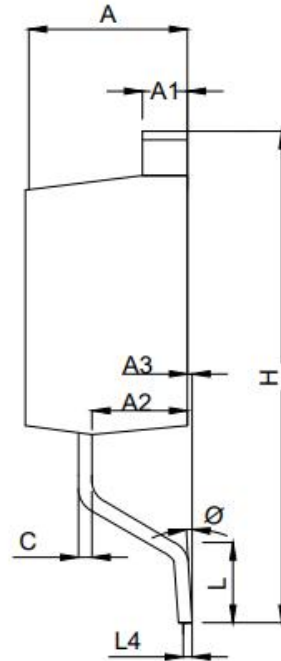
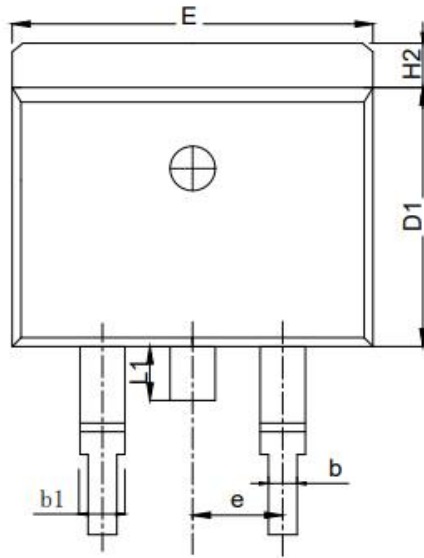
$$E_{AS} = \frac{1}{2} L_L I_{AS}^2$$



## Peak Diode Recovery dv/dt Test Circuit & Waveforms



## TO-263 OUTLINE



| Symbol | DIMENSIONS (unit:mm) |       |       |
|--------|----------------------|-------|-------|
|        | Min                  | Typ   | Max   |
| A      | 4.37                 | 4.57  | 4.77  |
| A1     | 1.22                 | 1.27  | 1.42  |
| A2     | 2.49                 | 2.69  | 2.89  |
| A3     | 0                    | 0.13  | 0.25  |
| b      | 0.7                  | 0.81  | 0.96  |
| b1     | 1.17                 | 1.27  | 1.47  |
| c      | 0.3                  | 0.38  | 0.53  |
| D1     | 8.5                  | 8.7   | 8.9   |
| D4     | 6.6                  | -     | -     |
| E      | 9.86                 | 10.16 | 10.36 |
| E5     | 7.06                 | -     | -     |
| e      | 2.54 BSC             |       |       |
| H      | 14.7                 | 15.1  | 15.5  |
| H2     | 1.07                 | 1.27  | 1.47  |
| L      | 2                    | 2.3   | 2.6   |
| L1     | 1.4                  | 1.55  | 1.7   |
| L4     | 0.25 BSC             |       |       |
| ?      | 0°                   | 5°    | 9°    |

## NOTE:

- 1The plastic package is not marked as smooth surface $R_a=0.1$ ;Subglossy surface $R_a=0.8$
- 2.Undeclared tolerance $\pm 0.25$ ,Unmarked fillet $R_{max}=0.25$

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